Search Notes



Application/Control	No.

Applicant(s)/Patent under Reexamination
ZHANG ET AL.

10/501,690 Examiner

Jason M. Nolan, Ph.D.

Art Unit 1626

SEARCHED				
Class	Subclass	Date	Examiner	
549	43, 57, 350, 387, 433, 436	2/5/2006	NML	
549	458	2/5/2006	JMN	
548	200, 236	2/5/2006	ЈМИ	
544	405	2/5/2006	JMN	
546	83, 284.1	2/5/2006	JMN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
544	405	2/5/2006	JMN	
546	83, 284.1	2/5/2006	JMN	
549	458	2/5/2006	JMN	
548, 514		2/5/2006	JMN	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor Search - Double Patenting Review	2/15/2006	JMN
STN CAPLUS Structure Search, printout attached	2/5/2006	NML
IDS Reviewed	2/5/2006	NML
Priority Documents Reviewed	2/5/2006	NML
BIB, Oath, Spec, Claims reviewed	2/5/2006	MML
Patentability Conference with SPE and Primary Examiners	2/28/2006	JMN